

**Nano-Characterization Facility
University of Texas at Dallas**

Internal User Rates

Equipment	Internal User Rate (USD/hour)
JEOL ARM 200F STEM	60
JEOL JEM 2100F TEM	50
FEI Nova 200 FIB	40
Zeiss Supra 40 SEM	40
NeoScope Benchtop SEM	15
Veeco Multimode V SPM	20
Rigaku Ultima III XRD	15
Rigaku SmartLab XRD	30
Optical Microscope	free